

# TRS3232E ±15kV IEC ESD 保護機能搭載、小型パッケージの 3V~5.5V マルチチャンネル RS-232 ラインドライバ/レシーバ

## 1 特長

- RS-232 バスピン用 ESD 保護機能
  - ±15kV (HBM)
  - ±8kV (IEC61000-4-2、接触放電)
  - ±15kV (IEC61000-4-2、気中放電)
- TIA/EIA-232-F および ITU V.28 規格の要件に適合またはそれを上回る性能
- 3V~5.5V の  $V_{CC}$  電源で動作
  - $V_{CC}$  が 2.7V まで下がっても RS-232 と相互運用可能
- 最大 250kbps で動作
- 2 つのドライバと 2 つのレシーバ
- 低い消費電流: 300 $\mu$ A (標準値)
- 外付けコンデンサ: 4 × 0.1 $\mu$ F
- 3.3V 電源で 5V ロジック入力を許容
- SOIC-16 よりも 85% 小さいニアチップスケールパッケージ (QFN-16、3mm x 3mm) で供給
- 代替の高速デバイス (1Mbps) とピン互換
  - SN65C3232E (-40°C~+85°C)
  - SN75C3232E (0°C~70°C)

## 2 アプリケーション

- 産業用 PC
- 有線ネットワーク
- データ・センターおよびエンタープライズ・コンピューティング
- バッテリー駆動システム
- ノートブック PC
- パームトップ PC
- ハンドヘルド機器

## 3 概要

TRS3232E デバイスは 2 つのラインドライバ、2 つのラインレシーバ、1 つのデュアルチャージポンプ回路で構成されており、ピン間 (シリアルポート接続ピン、GND を含む) に ±15kV の IEC ESD 保護機能を備えています。

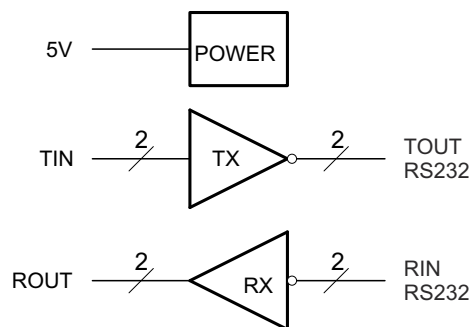
このデバイスは、TIA/EIA-232-F の要件を満たし、非同期通信コントローラとシリアルポートコネクタの間の電気的インターフェイスとして機能します。チャージポンプと 4 つの小さな外付けコンデンサにより、3V~5.5V の単一電源で動作できます。本デバイスは最大 250kbps/s のデータ信号速度、最大 30V/ $\mu$ s のドライバ出力カスルレートで動作します。

### パッケージ情報

部品番号	パッケージ (1)	パッケージサイズ (2)
TRS3232E	SOIC (D, 16)	9.9mm × 6mm
	SSOP (DB, 16)	6.2mm × 7.8mm
	SOIC (DW, 16)	10.3mm × 10.3mm
	TSSOP (PW, 16)	5mm × 6.4mm
	VQFN (RGT, 16)	3 mm × 3mm
	SOT-23-THN (DYY) (16)	4.2mm × 2mm

(1) 詳細については、[セクション 11](#) を参照してください。

(2) パッケージサイズ (長さ × 幅) は公称値で、該当する場合はピンも含まれます。



簡略ブロック図



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## 4 Pin Configuration and Functions

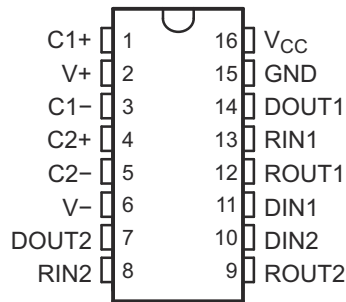


図 4-1. DB, PW or DYY Package  
16-Pin SSOP, TSSOP, or SOT-23-THN  
(Top View)

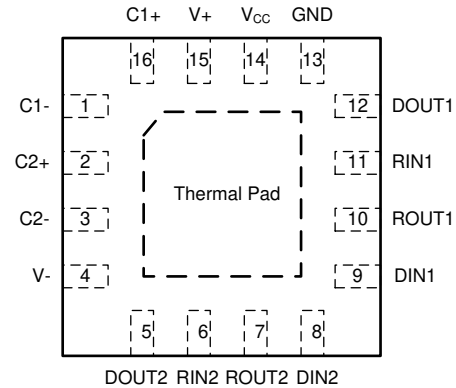


図 4-2. RGT package, 16 Pin VQFN, Top View

表 4-1. Pin Functions

PIN		RGT	TYPE	DESCRIPTION
NAME	NO.			
C1+	1	16	—	Positive lead of C1 capacitor
C1-	3	1	—	Negative lead of C1 capacitor
C2+	4	2	—	Positive lead of C2 capacitor
C2-	5	3	—	Negative lead of C2 capacitor
DIN1	11	9	I	Logic data input (from UART)
DIN2	10	8	I	Logic data input (from UART)
DOUT2	7	5	O	RS232 line data output (to remote RS232 system)
DOUT1	14	12	O	RS232 line data output (to remote RS232 system)
GND	15	13	—	Ground
RIN1	13	11	I	RS232 line data input (from remote RS232 system)
RIN2	8	6	I	RS232 line data input (from remote RS232 system)
ROUT2	9	7	O	Logic data output (to UART)
ROUT1	12	10	O	Logic data output (to UART)
V+	2	15	O	Positive charge pump output for storage capacitor only
V-	6	4	O	Negative charge pump output for storage capacitor only
V <sub>CC</sub>	16	14	—	Supply voltage, connect to external 3-V to 5.5-V power supply
Thermal Pad		Yes	—	Thermal pad for improving heat dissipation. Can be connected to GND or left floating.

## 5 Specifications

### 5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

		MIN	MAX	UNIT	
V <sub>CC</sub>	Supply voltage <sup>(2)</sup>	-0.3	6	V	
V+	Positive output supply voltage <sup>(2)</sup>	-0.3	7	V	
V-	Negative output supply voltage <sup>(2)</sup>	0.3	-7	V	
V+ - V-	Supply voltage difference <sup>(2)</sup>		13	V	
V <sub>I</sub>	Input voltage	Drivers	-0.3	6	V
		Receivers	-25	25	V
V <sub>O</sub>	Output voltage	Drivers	-13.2	13.2	V
		Receivers	-0.3	V <sub>CC</sub> + 0.3	V
T <sub>J</sub>	Operating virtual junction temperature		150	°C	
T <sub>stg</sub>	Storage temperature	-65	150	°C	

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltages are with respect to network GND.

### 5.2 ESD Ratings

			VALUE	UNIT	
V <sub>(ESD)</sub>	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/ JEDEC JS-001 <sup>(1)</sup>	All pins except RIN1, RIN2, DOUT1 and DOUT2	±2000	V
			Pins RIN1, RIN2, DOUT1 and DOUT2	±15000	
		Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup>	All pins	±1500	

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 5.3 ESD Ratings - IEC Specifications

			VALUE	UNIT	
V <sub>(ESD)</sub>	Electrostatic discharge	IEC 61000-4-2, Contact Discharge <sup>(1)</sup>	Pins RIN1, RIN2, DOUT1, DOUT2 <sup>(2)</sup>	±8000	V
		IEC 61000-4-2, Air-Gap Discharge <sup>(1)</sup>	Pins RIN1, RIN2, DOUT1, DOUT2 <sup>(2)</sup>	±15000	

- (1) For RGT, D, DB and PW packages only: Minimum of 1-μF capacitor between VCC and GND is required to meet the specified IEC 61000-4-2 rating.
- (2) For optimized IEC ESD performance for DYY package, the recommendation is to have series resistor (≥ 50Ω), on all logic inputs directly connected to power or ground, to minimize the transient currents going into or out of the logic pins.

## 5.4 Recommended Operating Conditions

See [8-1](#).<sup>(1)</sup>

		MIN	NOM	MAX	UNIT	
Supply voltage		$V_{CC} = 3.3\text{ V}$	3	3.3	3.6	V
		$V_{CC} = 5\text{ V}$	4.5	5	5.5	
$V_{IH}$	Driver high-level input voltage	DIN	$V_{CC} = 3.3\text{ V}$ 2      5.5 $V_{CC} = 5\text{ V}$ 2.4      5.5		V	
$V_{IL}$	Driver low-level input voltage	DIN	0	0.8	V	
$V_I$	Receiver input voltage	RIN	-25	25	V	
$T_A$	Operating free-air temperature	TRS3232EC	0	70	°C	
		TRS3232EI	-40	85		

(1) C1–C4 = 0.1  $\mu\text{F}$  at  $V_{CC} = 3.3\text{ V} \pm 0.3\text{ V}$ ; C1 = 0.047  $\mu\text{F}$ , C2–C4 = 0.33  $\mu\text{F}$  at  $V_{CC} = 5\text{ V} \pm 0.5\text{ V}$ .

## 5.5 Thermal Information

THERMAL METRIC <sup>(1)</sup>		TRS3232E					UNIT	
		PW (TSSOP)	D (SOIC)	DW (SOIC)	DB (SSOP)	RGT (VQFN)		DYY (SOT-23- THN)
		16 PINS	16 PINS	16 PINS	16 PINS	16 PINS		16 PINS
$R_{\theta JA}$	Junction-to-ambient thermal resistance	108.2	85.9	72.3	103.1	48.8	106.2	°C/W
$R_{\theta Jc\text{top}}$	Junction-to-case (top) thermal resistance	39.0	43.1	33.5	49.2	55.8	47.4	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	54.4	44.5	37.1	54.8	23.2	44.7	°C/W
$\Psi_{JT}$	Junction-to-top characterization parameter	3.3	10.1	7.5	12.0	1.7	1.7	°C/W
$\Psi_{JB}$	Junction-to-board characterization parameter	53.8	44.1	37.1	54.1	23.2	43.7	°C/W
$R_{\theta Jc\text{bot}}$	Junction-to-case (bottom) thermal resistance	N/A	N/A	N/A	N/A	9.0	N/A	°C/W

(1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report, [SPRA953](#).

## 5.6 Electrical Characteristics — Device

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see [Figure 8-1](#)).<sup>(1)</sup>

PARAMETER	TEST CONDITIONS	MIN	TYP <sup>(2)</sup>	MAX	UNIT
I <sub>CC</sub> Supply current	No load, V <sub>CC</sub> = 3.3 V or 5 V		0.3	1	mA

- (1) Test conditions are C1–C4 = 0.1 μF at V<sub>CC</sub> = 3.3 V ± 0.3 V; C1 = 0.047 μF, C2–C4 = 0.33 μF at V<sub>CC</sub> = 5 V ± 0.5 V.  
 (2) All typical values are at V<sub>CC</sub> = 3.3 V or V<sub>CC</sub> = 5 V, and T<sub>A</sub> = 25°C.

## 5.7 Electrical Characteristics — Driver

over operating free-air temperature range (unless otherwise noted) (see [Figure 8-1](#)).<sup>(1)</sup>

PARAMETER	TEST CONDITIONS	MIN	TYP <sup>(2)</sup>	MAX	UNIT
V <sub>OH</sub> High-level output voltage	DOUT at R <sub>L</sub> = 3 kΩ to GND, DIN = GND	5	5.4		V
V <sub>OL</sub> Low-level output voltage	DOUT at R <sub>L</sub> = 3 kΩ to GND, DIN = V <sub>CC</sub>	–5	–5.4		V
I <sub>IH</sub> High-level input current	V <sub>I</sub> = V <sub>CC</sub>		±0.01	±1	μA
I <sub>IL</sub> Low-level input current	V <sub>I</sub> at GND		±0.01	±1	μA
I <sub>OS</sub> <sup>(3)</sup> Short-circuit output current	V <sub>CC</sub> = 3.6 V, V <sub>O</sub> = 0 V		±35	±60	mA
	V <sub>CC</sub> = 5.5 V, V <sub>O</sub> = 0 V				
r <sub>O</sub> Output resistance	V <sub>CC</sub> , V+, and V– = 0 V, V <sub>O</sub> = ±2 V	300	10M		Ω

- (1) Test conditions are C1–C4 = 0.1 μF at V<sub>CC</sub> = 3.3 V ± 0.3 V; C1 = 0.047 μF, C2–C4 = 0.33 μF at V<sub>CC</sub> = 5 V ± 0.5 V.  
 (2) Short-circuit durations should be controlled to prevent exceeding the device absolute power dissipation ratings, and not more than one output should be shorted at a time.  
 (3) All typical values are at V<sub>CC</sub> = 3.3 V or V<sub>CC</sub> = 5 V, and T<sub>A</sub> = 25°C.

## 5.8 Electrical Characteristics — Receiver

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see [8-1](#)).<sup>(2)</sup>

PARAMETER		TEST CONDITIONS	MIN	TYP <sup>(1)</sup>	MAX	UNIT
V <sub>OH</sub>	High-level output voltage	I <sub>OH</sub> = –1 mA	V <sub>CC</sub> – 0.6	V <sub>CC</sub> – 0.1		V
V <sub>OL</sub>	Low-level output voltage	I <sub>OL</sub> = 1.6 mA			0.4	V
V <sub>IT+</sub>	Positive-going input threshold voltage	V <sub>CC</sub> = 3.3 V		1.5	2.4	V
		V <sub>CC</sub> = 5 V		1.8	2.4	
V <sub>IT–</sub>	Negative-going input threshold voltage	V <sub>CC</sub> = 3.3 V	0.6	1.2		V
		V <sub>CC</sub> = 5 V	0.8	1.5		
V <sub>hys</sub>	Input hysteresis (V <sub>IT+</sub> – V <sub>IT–</sub> )			0.3		V
r <sub>i</sub>	Input resistance	V <sub>I</sub> = ±3 V to ±25 V	3	5	7	kΩ

(1) All typical values are at V<sub>CC</sub> = 3.3 V or V<sub>CC</sub> = 5 V, and T<sub>A</sub> = 25°C.

(2) Test conditions are C1–C4 = 0.1 μF at V<sub>CC</sub> = 3.3 V ± 0.3 V; C1 = 0.047 μF, C2–C4 = 0.33 μF at V<sub>CC</sub> = 5 V ± 0.5 V.

## 5.9 Switching Characteristics

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see [8-1](#)).<sup>(1)</sup>

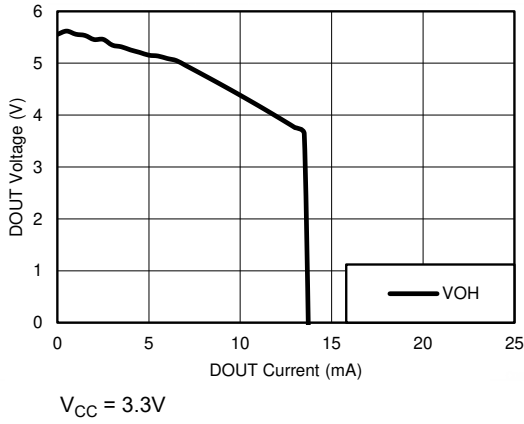
PARAMETER		TEST CONDITIONS	MIN	TYP <sup>(2)</sup>	MAX	UNIT
Maximum data rate		R <sub>L</sub> = 3 kΩ, C <sub>L</sub> = 1000 pF, see <a href="#">6-1</a> One DOUT switching,	RGT package	250	500	kbps
		D, DB, DW and PW packages	150	250		
t <sub>sk(p)</sub>	Driver pulse skew <sup>(3)</sup>	R <sub>L</sub> = 3 kΩ, C <sub>L</sub> = 1000 pF, V <sub>CC</sub> = 5 V <a href="#">6-2</a>	RGT package		50	ns
		R <sub>L</sub> = 3 kΩ to 7 kΩ, C <sub>L</sub> = 150 pF to 2500 pF see <a href="#">6-2</a>	D, DB, DW and PW packages		300	
SR(tr)	Driver slew rate, transition region (see <a href="#">6-1</a> )	R <sub>L</sub> = 3 kΩ to 7 kΩ, V <sub>CC</sub> = 3.3 V	C <sub>L</sub> = 150 pF to 1000 pF	6	30	V/μs
			C <sub>L</sub> = 150 pF to 2500 pF	4	30	
t <sub>PLH</sub>	Receiver propagation delay time, low- to high-level output	C <sub>L</sub> = 150 pF, see <a href="#">6-3</a>	RGT package		90	ns
			D, DB, DW and PW packages		300	
t <sub>PHL</sub>	Receiver propagation delay time, high- to low-level output	C <sub>L</sub> = 150 pF, see <a href="#">6-3</a>	RGT package		100	ns
			D, DB, DW and PW packages		300	
t <sub>sk(p)</sub>	Receiver pulse skew <sup>(3)</sup>		RGT package		20	ns
			D, DB, DW and PW packages		300	

(1) Test conditions are C1–C4 = 0.1 μF at V<sub>CC</sub> = 3.3 V ± 0.3 V; C1 = 0.047 μF, C2–C4 = 0.33 μF at V<sub>CC</sub> = 5 V ± 0.5 V.

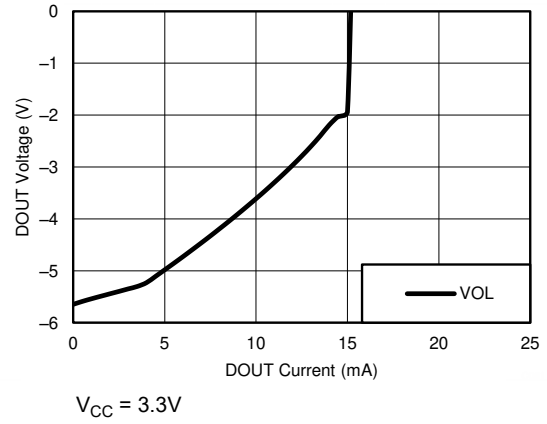
(2) All typical values are at V<sub>CC</sub> = 3.3 V or V<sub>CC</sub> = 5 V, and T<sub>A</sub> = 25°C.

(3) Pulse skew is defined as |t<sub>PLH</sub> – t<sub>PHL</sub>| of each channel of the same device.

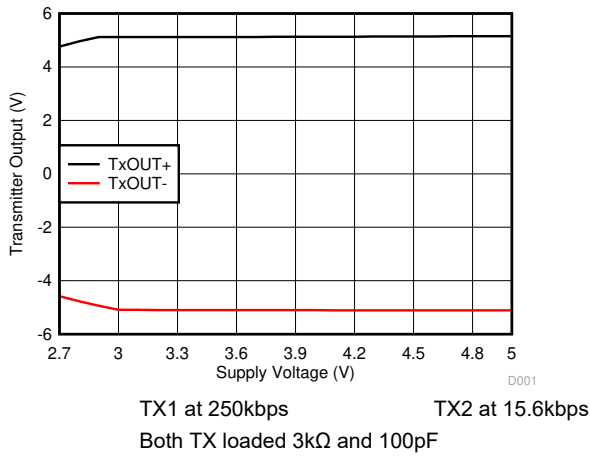
## Typical Characteristics



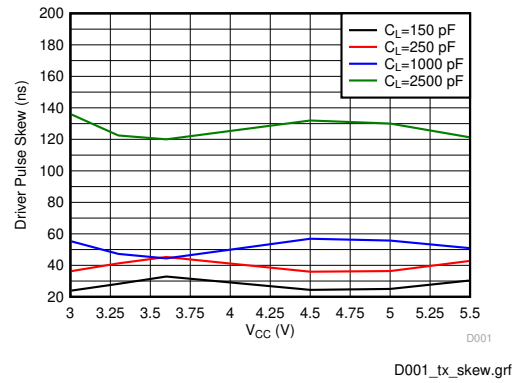
5-1. DOUT  $V_{OH}$  vs Load Current, Both Drivers Loaded



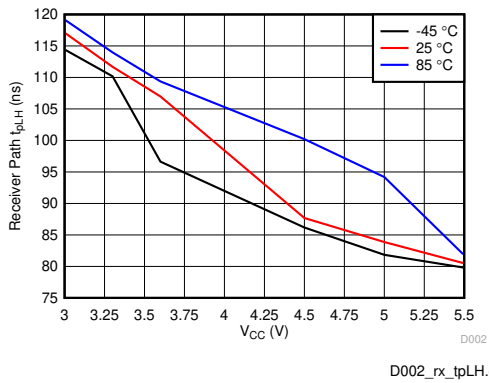
5-2. DOUT  $V_{OL}$  vs Load Current, Both Drivers Loaded



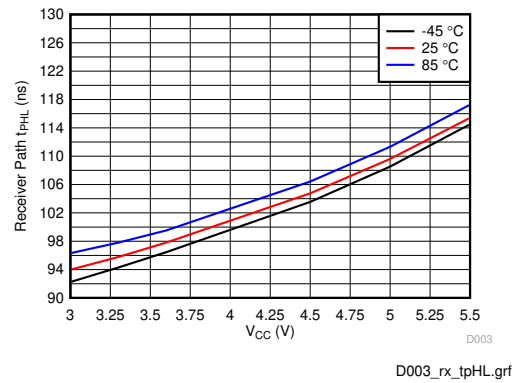
5-3. Driver Output Voltage vs. Supply Voltage, Both Drivers Loaded



5-4. Driver Pulse Skew (RGT Package)



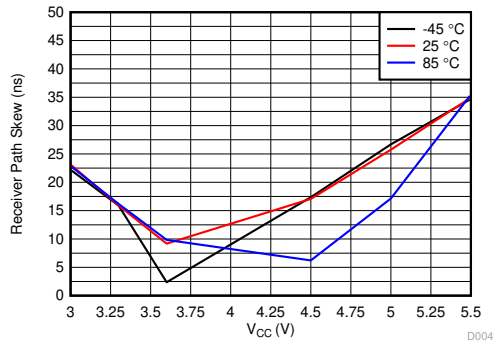
5-5. Receiver Path Low-to-High Propagation Delay (RGT Package)



5-6. Receiver Path High-to-Low Propagation Delay (RGT Package)



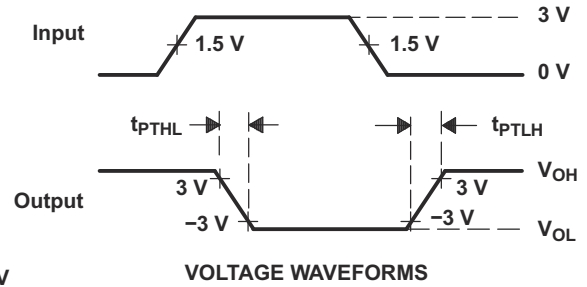
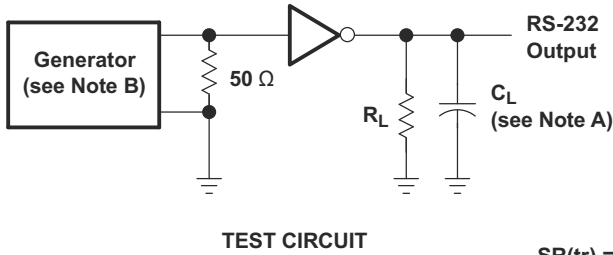
## Typical Characteristics



D004\_rx\_skew.grf

図 5-7. Receiver Path Skew ( $|t_{pHL} - t_{pLH}|$ ) (RGT Package)

## 6 Parameter Measurement Information

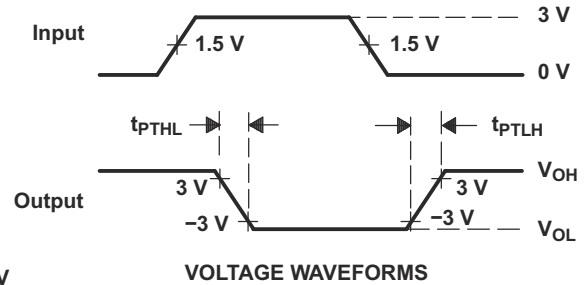
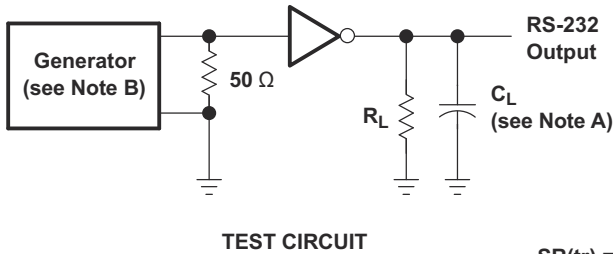


$$SR(tr) = \frac{6\text{ V}}{t_{PTHL} \text{ or } t_{PTLH}}$$

A.  $C_L$  includes probe and jig capacitance

B. The pulse generator has the following characteristics: PRR = 250 kbps,  $Z_O = 50\ \Omega$ , 50% duty cycle,  $t_r \leq 10\text{ ns}$ ,  $t_f \leq 10\text{ ns}$

### 图 6-1. Driver Slew Rate

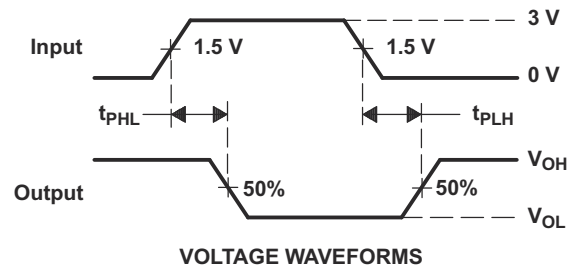
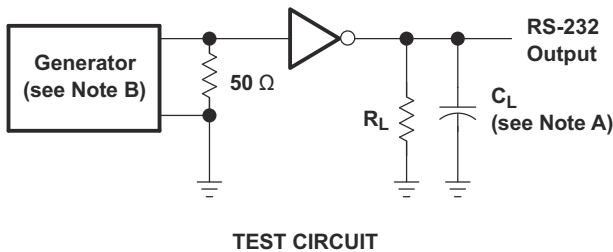


$$SR(tr) = \frac{6\text{ V}}{t_{PTHL} \text{ or } t_{PTLH}}$$

A.  $C_L$  includes probe and jig capacitance

B. The pulse generator has the following characteristics: PRR = 250 kbps,  $Z_O = 50\ \Omega$ , 50% duty cycle,  $t_r \leq 10\text{ ns}$ ,  $t_f \leq 10\text{ ns}$

### 图 6-2. Driver Pulse Skew



A.  $C_L$  includes probe and jig capacitance

B. The pulse generator has the following characteristics:  $Z_O = 50\ \Omega$ , 50% duty cycle,  $t_r \leq 10\text{ ns}$ ,  $t_f \leq 10\text{ ns}$

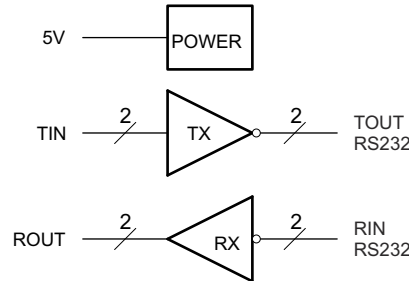
### 图 6-3. Receiver Propagation Delay Times

## 7 Detailed Description

### 7.1 Overview

The TRS3232E device consists of two line drivers, two-line receivers, and a dual charge-pump circuit with IEC61000-4-2 ESD protection terminal to terminal (serial-port connection terminals, including GND). The device meets the requirements of TIA/EIA-232-F and provides the electrical interface between an asynchronous communication controller and the serial-port connector. The charge pump and four small external capacitors allow operation from a single 3V to 5.5V supply. The device operates at data signaling rates up to 250kbps and a maximum of 30V/ $\mu$ s driver output slew rate. Outputs are protected against shorts to ground.

### 7.2 Functional Block Diagram



### 7.3 Feature Description

#### 7.3.1 Power

The power block increases, inverts, and regulates voltage at V+ and V– pins using a charge pump that requires four external capacitors.

#### 7.3.2 RS232 Driver

Two drivers interface standard logic level to RS232 levels. Both DIN inputs must be valid high or low.

#### 7.3.3 RS232 Receiver

Two receivers interface RS232 levels to standard logic levels. An open input will result in a high output on ROUT. Each RIN input includes an internal standard RS232 load.

## 7.4 Device Functional Modes

表 7-1 和 表 7-2 list the functional modes of the drivers and receivers of TRS3232E.

**表 7-1. Each Driver <sup>(1)</sup>**

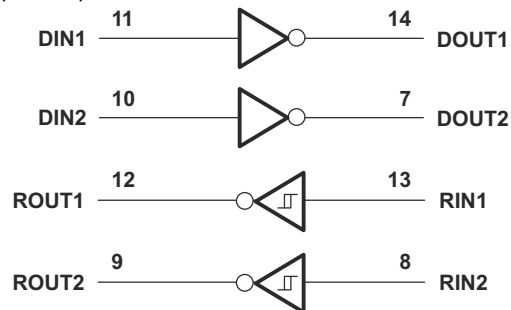
INPUT DIN	OUTPUT DOUT
L	H
H	L

(1) H = high level, L = low level

**表 7-2. Each Receiver <sup>(1)</sup>**

INPUT RIN	OUTPUT ROUT
L	H
H	L
Open	H

(1) H = high level, L = low level,  
Open = input disconnected or connected driver off



**図 7-1. Logic Diagram**

### 7.4.1 $V_{CC}$ Powered by 3V to 5.5V

The device is in normal operation.

### 7.4.2 $V_{CC}$ Unpowered, $V_{CC} = 0V$

When TRS3232E is unpowered, it can be safely connected to an active remote RS232 device.

## 8 Application and Implementation

### 注

以下のアプリケーション情報は、TI の製品仕様に含まれるものではなく、TI ではその正確性または完全性を保証いたしません。個々の目的に対する製品の適合性については、お客様の責任で判断していただくこととなります。お客様は自身の設計実装を検証しテストすることで、システムの機能を確認する必要があります。

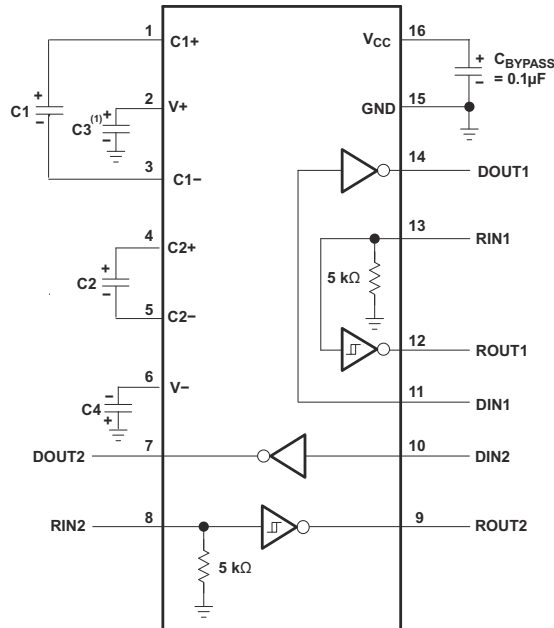
### 8.1 Application Information

The TRS3232E interfaces logic lines from a UART or microcontroller to the voltage and current levels needed for RS232 communication. The TIN inputs will accept 5V logic with 3.3V  $V_{CC}$  supply. All baud rates up to 250kbps are supported.

It is important to use the correct capacitors for the  $V_{CC}$  voltage. This will reduce ripple voltage on the TOUT outputs. If only one driver is needed, the unused driver input should be connected to  $V_{CC}$  or ground.

### 8.2 Typical Application

ROUT and DIN connect to UART or general-purpose logic lines. RIN and DOUT lines connect to a RS232 connector or cable. For proper operation, add capacitors as shown in 表 8-1.



A. C3 can be connected to  $V_{CC}$  or GND

Resistor values shown are nominal.

Nonpolarized ceramic capacitors are acceptable. If polarized tantalum or electrolytic capacitors are used, they should be connected as shown.

図 8-1. Typical Operating Circuit and Capacitor Values

表 8-1.  $V_{CC}$  vs Capacitor Values

$V_{CC}$	C1	C2, C3, C4
3.3V ± 0.3V	0.1μF	0.1μF
5V ± 0.5V	0.047μF	0.33μF
3V ± 5.5V	0.1μF	0.47μF

### 8.2.1 Design Requirements

The recommended  $V_{CC}$  is 3.3V or 5V. 3V to 5.5V is also possible.


The maximum recommended bit rate is 250kbps.

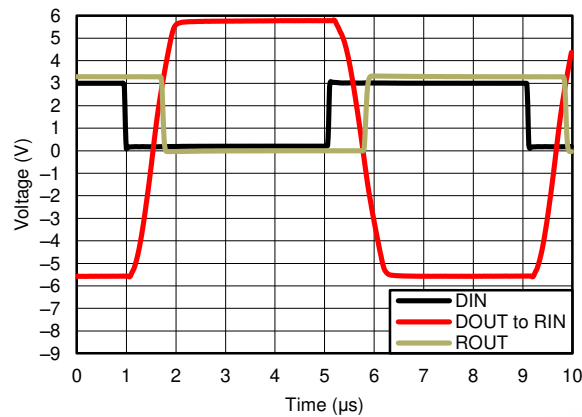
### 8.2.2 Detailed Design Procedure

All DIN inputs must be connected to valid low or high logic levels.

Select capacitor values based on  $V_{CC}$  level for best performance.

### 8.2.3 Application Curve

 8-2 curves are for 3.3V  $V_{CC}$  and 250kbps alternative bit data stream.



 8-2. 250kbps Driver to Receiver Loopback Timing Waveform,  $V_{CC}$  = 3.3V

## 8.3 Power Supply Recommendations

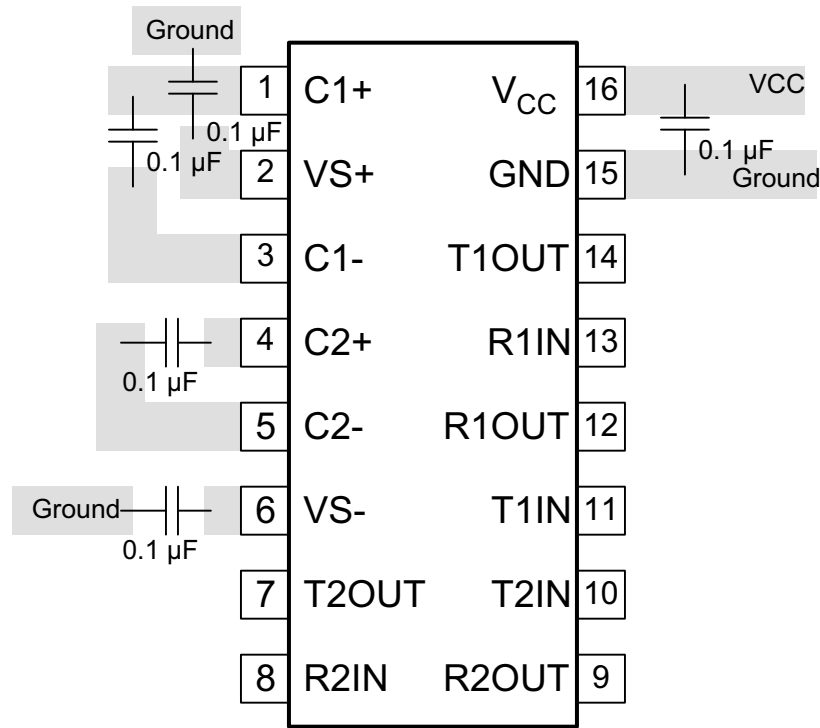
The supply voltage,  $V_{CC}$ , should be between 3V and 5.5V. Select the values of the charge-pump capacitors using 表 8-1.

## 8.4 Layout

### 8.4.1 Layout Guidelines

Keep the external capacitor traces short, specifically on the C1 and C2 nodes that have the fastest rise and fall times.

### 8.4.2 Layout Example



☒ 8-3. Layout Diagram

## 9 Device and Documentation Support

### 9.1 ドキュメントの更新通知を受け取る方法

ドキュメントの更新についての通知を受け取るには、[www.tij.co.jp](http://www.tij.co.jp) のデバイス製品フォルダを開いてください。[通知] をクリックして登録すると、変更されたすべての製品情報に関するダイジェストを毎週受け取ることができます。変更の詳細については、改訂されたドキュメントに含まれている改訂履歴をご覧ください。

### 9.2 サポート・リソース

テキサス・インスツルメンツ E2E™ サポート・フォーラムは、エンジニアが検証済みの回答と設計に関するヒントをエキスパートから迅速かつ直接得ることができる場所です。既存の回答を検索したり、独自の質問をしたりすることで、設計に必要な支援を迅速に得ることができます。

リンクされているコンテンツは、各寄稿者により「現状のまま」提供されるものです。これらはテキサス・インスツルメンツの仕様を構成するものではなく、必ずしもテキサス・インスツルメンツの見解を反映したものではありません。テキサス・インスツルメンツの[使用条件](#)を参照してください。

### 9.3 商標

テキサス・インスツルメンツ E2E™ is a trademark of Texas Instruments.

すべての商標は、それぞれの所有者に帰属します。

### 9.4 静電気放電に関する注意事項



この IC は、ESD によって破損する可能性があります。テキサス・インスツルメンツは、IC を取り扱う際には常に適切な注意を払うことを推奨します。正しい取り扱いおよび設置手順に従わない場合、デバイスを破損するおそれがあります。

ESD による破損は、わずかな性能低下からデバイスの完全な故障まで多岐にわたります。精密な IC の場合、パラメータがわずかに変化するだけで公表されている仕様から外れる可能性があるため、破損が発生しやすくなっています。

### 9.5 用語集

[テキサス・インスツルメンツ用語集](#) この用語集には、用語や略語の一覧および定義が記載されています。

## 10 Revision History

資料番号末尾の英字は改訂を表しています。その改訂履歴は英語版に準じています。

Changes from Revision D (June 2021) to Revision E (December 2024)	Page
「製品情報」表を「パッケージ情報」表に変更.....	1
データシートに SOT-23-THN (DYY) パッケージを追加.....	1
Added Note 2 to the ESD ratings - IEC Specifications .....	4


Changes from Revision C (June 2021) to Revision D (June 2021)	Page
「アプリケーション」を追加産業用 PC、有線ネットワーク、データ・センター、エンタープライズ・コンピューティング .....	1
Changed the table note in the ESD Ratings - IEC Specifications to make it applicable to D, DB and PW packages. ....	4
Changed the thermal parameter values for D, DB and PW packages in the Thermal Information table.....	5

Changes from Revision B (October 2017) to Revision C (June 2021)	Page
製品情報に RGT パッケージを追加 .....	1
Added the RGT Pin Configuration .....	3
Added the ESD Ratings - IEC Specifications .....	4
Added RGT to the Thermal Information .....	5
Added RGT package to the Switching Characteristics .....	7



- Changed the capacitor value From: 1  $\mu$ f To: 0.1  $\mu$ f in the *Layout Diagram* ..... 15

**Changes from Revision A (July 2015) to Revision B (October 2017) Page**

- 「特長」に以下を追加:  $V_{CC}$  が 2.7V まで下がっても RS-232 と相互運用可能..... 1
- Added  5-3 ..... 8

**Changes from Revision \* (April 2007) to Revision A (July 2015) Page**

- 「注文情報」表を削除。 ..... 1
- 「製品情報」表、「ピン構成および機能」セクション、「ESD 定格」表、「熱に関する情報」表、「機能説明」セクション、「デバイスの機能モード」、「アプリケーションと実装」セクション、「電源に関する推奨事項」セクション、「レイアウト」セクション、「デバイスおよびドキュメントのサポート」セクション、「メカニカル、パッケージ、および注文情報」セクションを追加。 ..... 1

## 11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser based versions of this data sheet, refer to the left hand navigation.

**PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TRS3232ECDR	ACTIVE	SOIC	D	16	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	TRS3232EC	<a href="#">Samples</a>
TRS3232ECDW	OBSOLETE	SOIC	DW	16		TBD	Call TI	Call TI	0 to 70	TRS3232EC	
TRS3232ECDWR	ACTIVE	SOIC	DW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	TRS3232EC	<a href="#">Samples</a>
TRS3232ECPWR	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	RS32EC	<a href="#">Samples</a>
TRS3232EIDBR	ACTIVE	SSOP	DB	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	RS32EI	<a href="#">Samples</a>
TRS3232EIDR	ACTIVE	SOIC	D	16	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TRS3232EI	<a href="#">Samples</a>
TRS3232EIDW	OBSOLETE	SOIC	DW	16		TBD	Call TI	Call TI	-40 to 85	TRS3232EI	
TRS3232EIDWR	OBSOLETE	SOIC	DW	16		TBD	Call TI	Call TI	-40 to 85	TRS3232EI	
TRS3232EIDYYR	ACTIVE	SOT-23-THIN	DYY	16	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	RS32EI	<a href="#">Samples</a>
TRS3232EIPWR	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	RS32EI	<a href="#">Samples</a>
TRS3232EIPWRG4	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	RS32EI	<a href="#">Samples</a>
TRS3232EIRGTR	ACTIVE	VQFN	RGT	16	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	3232	<a href="#">Samples</a>

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

**Important Information and Disclaimer:**The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

**OTHER QUALIFIED VERSIONS OF TRS3232E :**

- Automotive : [TRS3232E-Q1](#)

NOTE: Qualified Version Definitions:

- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

**TAPE AND REEL INFORMATION**

**QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE**


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TRS3232ECDR	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
TRS3232ECDWR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1
TRS3232ECPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
TRS3232ECPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
TRS3232EIDBR	SSOP	DB	16	2000	330.0	16.4	8.35	6.6	2.4	12.0	16.0	Q1
TRS3232EIDR	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
TRS3232EIDYYR	SOT-23-THIN	DYY	16	3000	330.0	12.4	4.8	3.6	1.6	8.0	12.0	Q3
TRS3232EIPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
TRS3232EIPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
TRS3232EIRGTR	VQFN	RGT	16	3000	330.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2

**TAPE AND REEL BOX DIMENSIONS**


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TRS3232ECDR	SOIC	D	16	2500	356.0	356.0	35.0
TRS3232ECDWR	SOIC	DW	16	2000	350.0	350.0	43.0
TRS3232ECPWR	TSSOP	PW	16	2000	367.0	367.0	35.0
TRS3232ECPWR	TSSOP	PW	16	2000	356.0	356.0	35.0
TRS3232EIDBR	SSOP	DB	16	2000	356.0	356.0	35.0
TRS3232EIDR	SOIC	D	16	2500	356.0	356.0	35.0
TRS3232EIDYYR	SOT-23-THIN	DYY	16	3000	336.6	336.6	31.8
TRS3232EIPWR	TSSOP	PW	16	2000	356.0	356.0	35.0
TRS3232EIPWR	TSSOP	PW	16	2000	367.0	367.0	35.0
TRS3232EIRGTR	VQFN	RGT	16	3000	367.0	367.0	35.0



4224642/D 07/2024

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.50 per side.
5. Reference JEDEC Registration MO-345, Variation AA



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE: 20X



4224642/D 07/2024

NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL  
SCALE: 20X

4224642/D 07/2024

NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



## GENERIC PACKAGE VIEW

**DW 16**

**SOIC - 2.65 mm max height**

7.5 x 10.3, 1.27 mm pitch

SMALL OUTLINE INTEGRATED CIRCUIT

This image is a representation of the package family, actual package may vary.  
Refer to the product data sheet for package details.



4224780/A



DW0016A

# PACKAGE OUTLINE

SOIC - 2.65 mm max height

SOIC



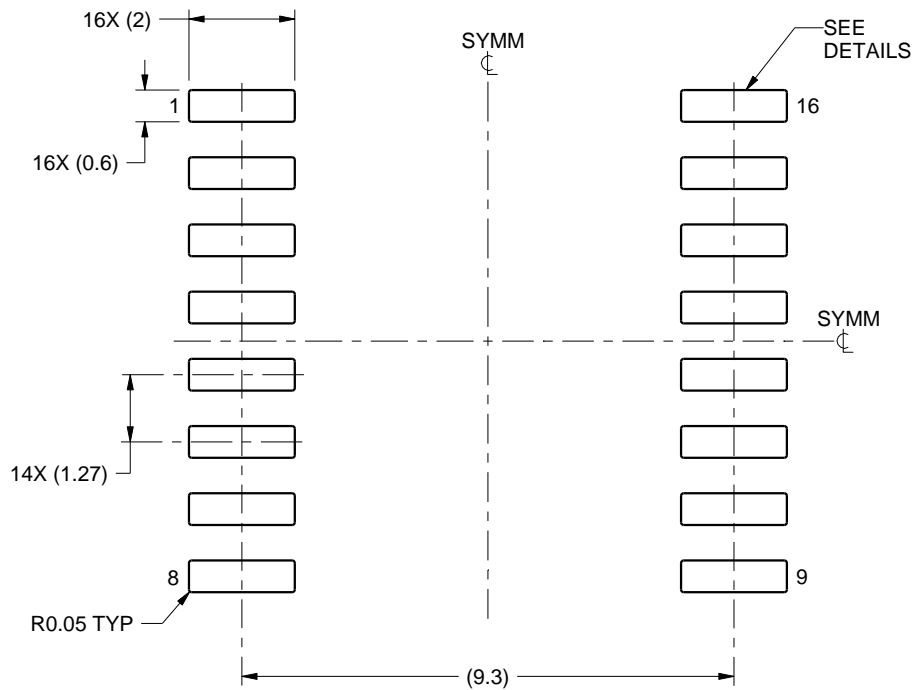
4220721/A 07/2016

# EXAMPLE BOARD LAYOUT

DW0016A

SOIC - 2.65 mm max height

SOIC



LAND PATTERN EXAMPLE  
SCALE:7X



SOLDER MASK DETAILS

4220721/A 07/2016

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

# EXAMPLE STENCIL DESIGN

DW0016A

SOIC - 2.65 mm max height

SOIC



SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL  
SCALE:7X

4220721/A 07/2016

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

**RGT 16**

**GENERIC PACKAGE VIEW**

**VQFN - 1 mm max height**

PLASTIC QUAD FLATPACK - NO LEAD



Images above are just a representation of the package family, actual package may vary.  
Refer to the product data sheet for package details.

4203495/1



SIDE WALL METAL THICKNESS DIM A	
OPTION 1	OPTION 2
0.1	0.2



4222419/D 04/2022

NOTES:

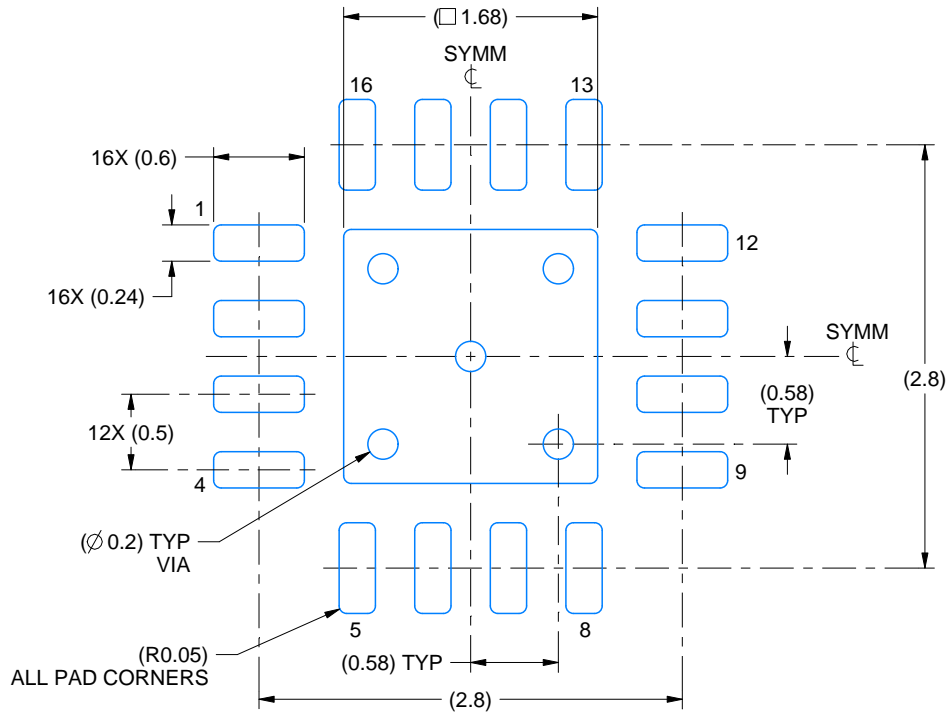
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

# EXAMPLE BOARD LAYOUT

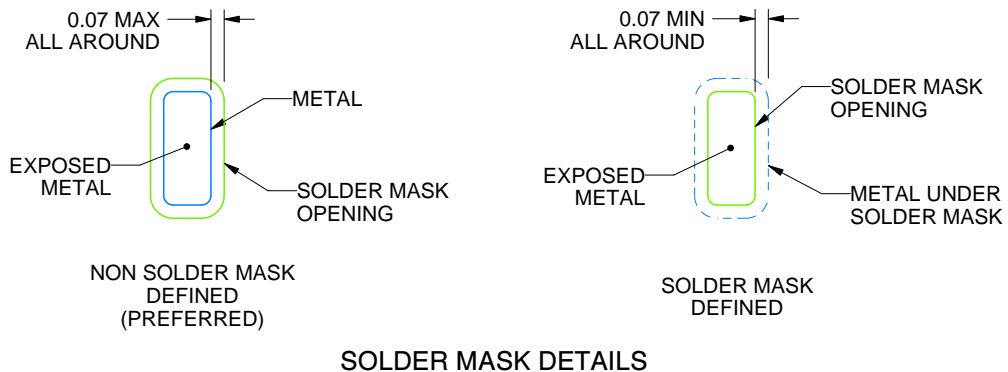
RGT0016C

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



**LAND PATTERN EXAMPLE**  
EXPOSED METAL SHOWN  
SCALE:20X



**SOLDER MASK DETAILS**

4222419/D 04/2022

NOTES: (continued)

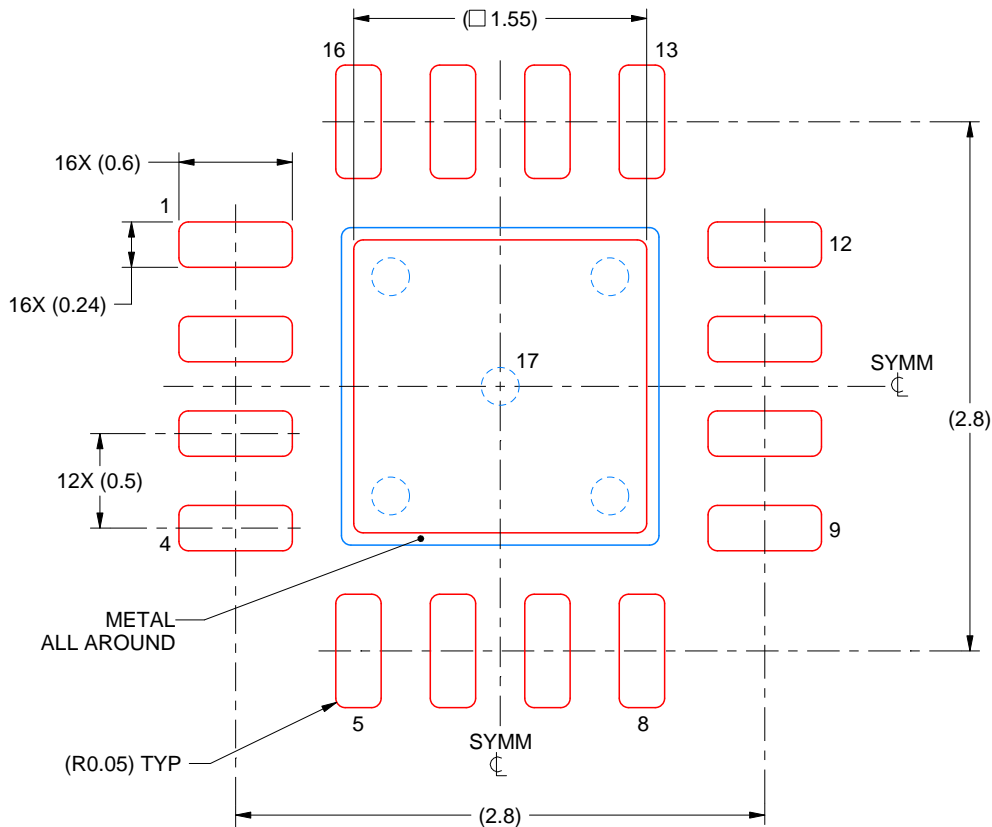
4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 ([www.ti.com/lit/slua271](http://www.ti.com/lit/slua271)).
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

# EXAMPLE STENCIL DESIGN

RGT0016C

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



**SOLDER PASTE EXAMPLE**  
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD 17:  
85% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE  
SCALE:25X

4222419/D 04/2022

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



D (R-PDSO-G16)

PLASTIC SMALL OUTLINE



4040047-6/M 06/11

- NOTES:
- A. All linear dimensions are in inches (millimeters).
  - B. This drawing is subject to change without notice.
  -  Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
  -  Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
  - E. Reference JEDEC MS-012 variation AC.



4220204/A 02/2017

**NOTES:**

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-153.

# EXAMPLE BOARD LAYOUT

PW0016A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE: 10X



SOLDER MASK DETAILS

4220204/A 02/2017

NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

# EXAMPLE STENCIL DESIGN

PW0016A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL  
SCALE: 10X

4220204/A 02/2017

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

# DB0016A



# PACKAGE OUTLINE

## SSOP - 2 mm max height

SMALL OUTLINE PACKAGE



4220763/A 05/2022

### NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. Reference JEDEC registration MO-150.

# EXAMPLE BOARD LAYOUT

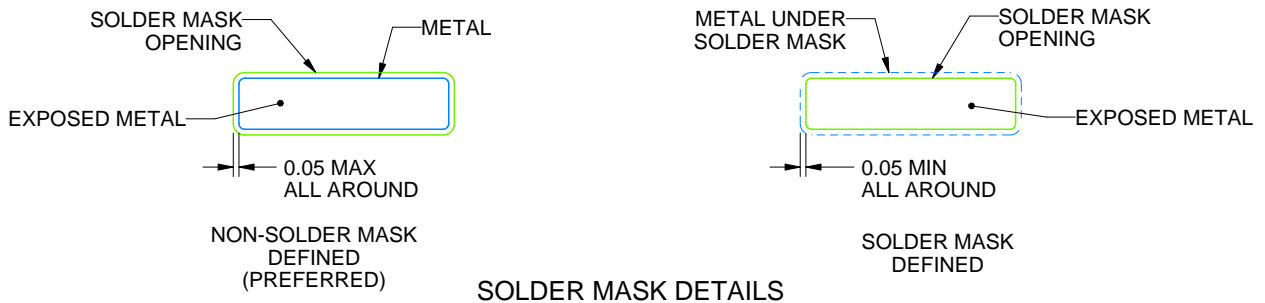
DB0016A

SSOP - 2 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE: 10X



4220763/A 05/2022

NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

# EXAMPLE STENCIL DESIGN

DB0016A

SSOP - 2 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL  
SCALE: 10X

4220763/A 05/2022

NOTES: (continued)

7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
8. Board assembly site may have different recommendations for stencil design.

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